

Product Change Notification - LIAL-31LFQR391

Date: 08 Jun 2020 Product Category: Memory Affected CPNs: ☑ Notification subject: CCB 4255 Initial Notice: Qualification

CCB 4255 Initial Notice: Qualification of GTK as a new assembly site for selected Atmel AT27C0xx device families available in 32L PDIP (.600in) package.

Notification text:

PCN Status: Initial notification.

PCN Type: Manufacturing Change

Microchip Parts Affected:

Please open one of the icons found in the Affected CPNs section above.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:

Qualification of GTK as a new assembly site for selected Atmel AT27C0xx device families available in 32L PDIP (.600in) package.

Pre Change:

Assembled at LPI using CRM-1033BF die attach, QI-4939 die coat and G600 molding compound material

Post Change:

Assembled at GTK using EN-4900GC die attach, PIX-8144 die coat and G631M molding compound material

Pre and Post Change Summary:

| | Pre Change | Post Change | | |
|------------------------------|---------------------------------------|---------------------------|--|--|
| Assembly Site | Lingsen Precision Industries, LTD. | GREATEK ELETRONIC INC. | | |
| | (LPI) | (GTK) | | |
| Wire material | Au | Au | | |
| Die attach material | CRM-1033BF | EN-4900GC | | |
| Die coat material | QI-4939 | PIX-8144 | | |
| Molding compound material | G600 | G631M | | |



| Lead fram | e material | A194 | A194 | | | | |
|-----------|------------|------------------------------------|------------------------------------|--|--|--|--|
| | Base | | | | | | |
| | Quantity | 12 | 12 | | | | |
| | Multiple | 12 | 12 | | | | |
| | (BQM) | | | | | | |
| Packing | Tube Color | Clear | Clear | | | | |
| media | Plug Color | White / Green | White / Blue | | | | |
| | Tube | | | | | | |
| (Tube) | Dimension | Minor dimensional cha | anges. See pre and post comparison | | | | |
| | and | change of | | | | | |
| | (Length) | | | | | | |
| | Tube | See pre and post | change comparison | | | | |
| | Drawing | See pre and post change comparison | | | | | |

Impacts to Data Sheet:

None

Change Impact:

None

Reason for Change:

To improve on-time delivery performance by qualifying GTK as a new assembly site

Change Implementation Status:

In Progress

Estimated Qualification Completion Date:

November 2020

Note: Please be advised the qualification completion times may be extended because of unforeseen business conditions however implementation will not occur until after qualification has completed and a final PCN has been issued. The final PCN will include the qualification report and estimated first ship date. Also note that after the estimated first ship date guided in the final PCN customers may receive pre and post change parts.

Time Table Summary:

| | | Ju | ine 20 | 20 | | > | November 2020 | | | | | | |
|--------------------------|----|----|--------|----|----|---|---------------|----|----|----|----|--|--|
| Workweek | 23 | 24 | 25 | 26 | 27 | / | 45 | 46 | 47 | 48 | 49 | | |
| Initial PCN Issue Date | | Х | | | | | | | | | | | |
| Qual Report Availability | | | | | | | | | | | Х | | |
| Final PCN Issue Date | | | | | | | | | | | Х | | |

Method to Identify Change:

Traceability code.

Qualification Plan:

Please open the attachments included with this PCN labeled as PCN_#_Qual_Plan.

Revision History:



June 8, 2020: Issued initial notification.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachment(s): <u>PCN_LIAL-31LFQR391_QUAL PLAN.pdf</u> <u>PCN_LIAL-31LFQR391_Packing Pre and Post Change.pdf</u>

Please contact your local <u>Microchip sales office</u> with questions or concerns regarding this notification.

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LIAL-31LFQR391 - CCB 4255 Initial Notice: Qualification of GTK as a new assembly site for selected Atmel AT27C0xx device families available in 32L PDIP (.600in) package.

Affected Catalog Part Numbers (CPN)

AT27C020-55PU AT27C020-90PU AT27C040-70PU AT27C040-90PU AT27C080-90PU AT27C010-70PU

CCB 4255 Pre and Post Change Summary PCN# LIAL-31LFQR391

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Packing Information (Tube Comparison)

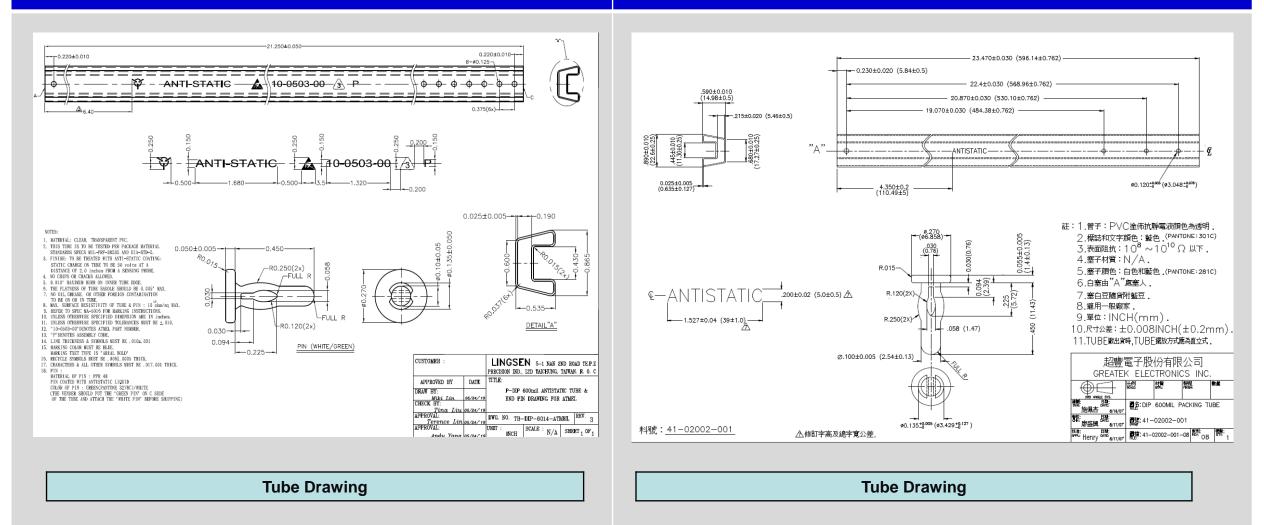
| | | PRE- | CHANGE (I | LPI) | | POST-CHANGE (GTK) | | | | | | | |
|---------|---------------|--------------|------------|-------------------------------------|-------------|-------------------|---------------|--------------|------------|-------------------|------------|--|--|
| | ANTI-STATIC | anti-static | | 10-0503-00 10-0503-00 🎄 Р | P | | ANTISTATIC | | ANTISTATIC | - | | | |
| Package | Lead Count | Body Size | Units/Tube | Length (inch) | End Plugs | Package | Lead Count | Body Size | Units/Tube | Length (inch) | End Plugs | | |
| PDIP | 32 | 600 mils | 12 | 20.250+/- 0.050 | White/Green | PDIP | 32 | 600 mils | 12 | 23.47+/- 0.030 | White/Blue | | |



Packing Information (Tube Comparison)

PRE-CHANGE (LPI)

POST-CHANGE (GTK)







QUALIFICATION PLAN SUMMARY

PCN#: LIAL-31LFQR391

May 28, 2020

Qualification of GTK as a new assembly site for selected Atmel AT27C0xx device families available in 32L PDIP (.600in) package. Purpose: Qualification of GTK as a new assembly site for selected Atmel AT27C0xx device families available in 32L PDIP (.600in) package.

| | Assembly site | GTK | | | | | |
|---------------|---|----------------------------|--|--|--|--|--|
| | MP Code (MPC) | 34A127P2XC01 | | | | | |
| | CCB # | 4255 | | | | | |
| | Part Number (CPN) | AT27C080-90PU | | | | | |
| <u>Misc.</u> | Assembly Shipping Media (T/R, Tube/Tray) | Tube (GTK 41-02002-001) | | | | | |
| | Base Quantity Multiple (BQM) | 12 | | | | | |
| | Reliability Site | MPHIL | | | | | |
| | Paddle size | 330 x 360 | | | | | |
| | Material | A194 | | | | | |
| | DAP Surface Prep | Spot Plating | | | | | |
| | Treatment | None | | | | | |
| Lood Frama | Process | Stamped | | | | | |
| Lead-Frame | Lead-lock | Yes | | | | | |
| | Part Number | 11-01032-007 | | | | | |
| | Lead Plating | Matte Sn | | | | | |
| | Strip Size (mm) | 1X6 | | | | | |
| | Strip Density | 6 ea/strip | | | | | |
| Bond Wire | Material | Au | | | | | |
| Die Attach | Part Number | EN-4900GC | | | | | |
| | Conductive | Yes | | | | | |
| Mold Compound | Part Number | G631M | | | | | |
| | PKG Type | PDIP | | | | | |
| <u>PKG</u> | Pin/Ball Count | 32 | | | | | |
| | PKG width/size | 600 mils | | | | | |

| Test Name | Conditions | Sample Size | Min. Qty of Spares per Lot (should be properly marked) | Qty of Lots | Total Units | Fail Accept Qty | Est. Dur. Days | ATE Test Site | REL Test Site | Pkg. Type | Special Instructions |
|---------------------------------------|---|--|---|-------------------|----------------|--|----------------------|---------------------|---------------------|--------------|--|
| Standard Pb- free Solderability | J-STD-002D ; Perform 8 hour steam aging for Matte tin finish and 1 hour steam aging for NiPdAu finish prior to testing. Standard Pb-free: Matte tin/ NiPdAu finish, SAC solder, wetting temp 245°C for both SMD & through hole packages. | 22 | 5 | 1 | 27 | > 95% lead coverage | 5 | MPHIL | MPHIL | PDIL32L | Standard Pb-free solderability is the requirement. SnPb solderability (backward solderability- SMD reflow soldering) is required for any plating related changes and highly recommended for other package BOM changes. |
| Wire Bond Pull - WBP | Mil. Std. 883-2011 | 5 | 0 | 1 | 5 | 0 fails after TC | 5 | MPHIL | MPHIL | PDIL32L | 30 bonds from a min. 5 devices. |
| Wire Bond Shear - WBS | CDF-AEC-Q100-001 | 5 | 0 | 1 | 5 | 0 | 5 | MPHIL | MPHIL | PDIL32L | 30 bonds from a min. 5 devices. |
| Physical Dimensions | Measure per JESD22 B100 and B108 | 10 | 0 | 3 | 30 | 0 | 5 | MPHIL | MPHIL | PDIL32L | |
| Lead Integrity | JESD22 B105 | 5 | 0 | 1 | 5 | 0 (No lead breakage or cracks) | 5 | MPHIL | MPHIL | PDIL32L | 10 leads from each of 5 parts. Not required for SMD, only required for through-hole. |
| External Visual | Mil. Std. 883-2009/2010 | All devices prior to submission for qualification testing | 0 | 3 | ALL | 0 | 5 | MPHIL | MPHIL | PDIL32L | |

| Preconditioning - Required for surface mount devices | +150°C Bake for 24 hours, moisture loading requirements per MSL level + 3X reflow at peak reflow temperature per Jedec-STD-020E for package type; Electrical test pre and post stress at +25°C. | 231 | 15 | 3 | 738 | 0 | 15 | MPHIL | MPHIL | PDIL32L | Spares should be properly identified. 77 parts from each lot to be used for HAST, uHAST, Temp Cycle test. |
|---|---|-----|----|---|-----|---|----|-------|-------|---------|---|
| HAST | +130°C/85% RH for 96 hours or 110°C/85%RH for 264 hours. Electrical test pre and post stress at hot temp. | 77 | 5 | 3 | 246 | 0 | 10 | MPHIL | MPHIL | PDIL32L | Spares should be properly identified. Use the parts which have gone through Pre- conditioning. |
| UHAST | +130°C/85% RH for 96 hrs or +110°C/85% RH for 264 hrs. Electrical test pre and post stress at hot temp. | 77 | 5 | 3 | 246 | 0 | 10 | MPHIL | MPHIL | PDIL32L | Spares should be properly identified. Use the parts which have gone through Pre- conditioning. |
| Temp Cycle | -65°C to +150°C for 500 cycles. Electrical test pre and post stress at hot temp; 3 gram force WBP, on 5 devices from 1 lot, test following Temp Cycle stress. | 77 | 5 | 3 | 246 | 0 | 15 | MPHIL | MPHIL | PDIL32L | Spares should be properly identified. Use the parts which have gone through Pre- conditioning. |